

Data sheet acquired from Harris Semiconductor SCHS163F

September 1997 - Revised October 2003

# High-Speed CMOS Logic Presettable Synchronous 4-Bit Up/Down Counters

#### Features

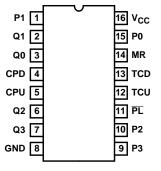
- Synchronous Counting and Asynchronous Loading
- . Two Outputs for N-Bit Cascading
- Look-Ahead Carry for High-Speed Counting
- Fanout (Over Temperature Range)
  - Standard Outputs......10 LSTTL Loads
  - Bus Driver Outputs ........... 15 LSTTL Loads
- Wide Operating Temperature Range ... -55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
  - 2V to 6V Operation
  - High Noise Immunity:  $N_{IL}$  = 30%,  $N_{IH}$  = 30% of  $V_{CC}$  at  $V_{CC}$  = 5V
- HCT Types
  - 4.5V to 5.5V Operation
  - Direct LSTTL Input Logic Compatibility, V<sub>IL</sub>= 0.8V (Max), V<sub>IH</sub> = 2V (Min)
  - CMOS Input Compatibility,  $I_I \le 1\mu A$  at  $V_{OL}$ ,  $V_{OH}$

#### Description

The 'HC192, 'HC193 and 'HCT193 are asynchronously presettable BCD Decade and Binary Up/Down synchronous counters, respectively.

#### **Pinout**

CD54HC192, CD54HC193, CD54HCT193 (CERDIP)
CD74HC192 (PDIP, SOP, TSSOP)
CD74HC193 (PDIP, SOIC)
CD74HCT193 (PDIP)
TOP VIEW



Presetting the counter to the number on the preset data inputs (P0-P3) is accomplished by a LOW asynchronous parallel load input (PL). The counter is incremented on the low-to-high transition of the Clock-Up input (and a high level on the Clock-Down input) and decremented on the low to high transition of the Clock-Down input (and a high level on the Clock-up input). A high level on the MR input overrides any other input to clear the counter to its zero state. The Terminal Count up (carry) goes low half a clock period before the zero count is reached and returns to a high level at the zero count. The Terminal Count Down (borrow) in the count down mode likewise goes low half a clock period before the maximum count (9 in the 192 and 15 in the 193) and returns to high at the maximum count. Cascading is effected by connecting the carry and borrow outputs of a less significant counter to the Clock-Up and Clock-Down inputs, respectively, of the next most significant counter.

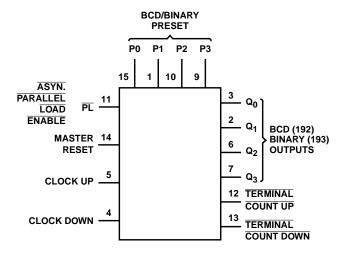
If a decade counter is preset to an illegal state or assumes an illegal state when power is applied, it will return to the normal sequence in one count as shown in state diagram.

### **Ordering Information**

PART NUMBER	TEMP. RANGE (°C)	PACKAGE
CD54HC192F3A	-55 to 125	16 Ld CERDIP
CD54HC193F3A	-55 to 125	16 Ld CERDIP
CD54HCT193F3A	-55 to 125	16 Ld CERDIP
CD74HC192E	-55 to 125	16 Ld PDIP
CD74HC192NSR	-55 to 125	16 Ld SOP
CD74HC192PW	-55 to 125	16 Ld TSSOP
CD74HC192PWR	-55 to 125	16 Ld TSSOP
CD74HC192PWT	-55 to 125	16 Ld TSSOP
CD74HC193E	-55 to 125	16 Ld PDIP
CD74HC193M	-55 to 125	16 Ld SOIC
CD74HC193MT	-55 to 125	16 Ld SOIC
CD74HC193M96	-55 to 125	16 Ld SOIC
CD74HCT193E	-55 to 125	16 Ld PDIP

NOTE: When ordering, use the entire part number. The suffixes 96 and R denote tape and reel. The suffix T denotes a small-quantity reel of 250.

# Functional Diagram



#### **TRUTH TABLE**

CLOCK UP	CLOCK DOWN	RESET	PARALLEL LOAD	FUNCTION
1	Н	L	Н	Count Up
Н	1	L	Н	Count Down
Х	Х	Н	Х	Reset
Х	Х	L	L	Load Preset Inputs

 $H = High \ Voltage \ Level, \ L = Low \ Voltage \ Level, \ X = Don't \ Care, \ \uparrow = Transition \ from \ Low \ to \ High \ Level$ 

### **Absolute Maximum Ratings**

DC Supply Voltage, V <sub>CC</sub>	-0.5V to 7V
DC Input Diode Current, I <sub>IK</sub>	
For $V_1 < -0.5V$ or $V_1 > V_{CC} + 0.5V$	±20mA
DC Output Diode Current, I <sub>OK</sub>	
For $V_O < -0.5V$ or $V_O > V_{CC} + 0.5V$	±20mA
DC Output Source or Sink Current per Output Pin, IO	
For $V_O > -0.5V$ or $V_O < V_{CC} + 0.5V$	±25mA
DC V <sub>CC</sub> or Ground Current, I <sub>CC or</sub> I <sub>GND</sub>	

#### **Thermal Information**

Package Thermal Impedance, θ <sub>JA</sub> (see Note 1):
E (PDIP) Package
M (SOIC) Package73°C/W
NS (SOP) Package
PW (TSSOP) Package 108°C/W
Maximum Junction Temperature
Maximum Storage Temperature Range65°C to 150°C
Maximum Lead Temperature (Soldering 10s)300°C
(SOIC - Lead Tips Only)

#### **Operating Conditions**

Temperature Range (T <sub>A</sub> )55°C to 125°C
Supply Voltage Range, V <sub>CC</sub>
HC Types2V to 6V
HCT Types
DC Input or Output Voltage, $V_I$ , $V_O$ 0V to $V_{CC}$
Input Rise and Fall Time
2V
4.5V 500ns (Max)
6V

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1. The package thermal impedance is calculated in accordance with JESD 51-7.

#### **DC Electrical Specifications**

		TEST CONDITIONS				25°C		-40°C T	O 85°C	-55°C T				
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)	V <sub>CC</sub> (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS		
HC TYPES														
High Level Input	V <sub>IH</sub>	-	-	2	1.5	-	-	1.5	-	1.5	-	V		
Voltage				4.5	3.15	-	-	3.15	-	3.15	-	V		
				6	4.2	-	-	4.2	-	4.2	-	V		
Low Level Input	V <sub>IL</sub>	-	-	2	-	-	0.5	-	0.5	-	0.5	V		
Voltage				4.5	-	-	1.35	-	1.35	-	1.35	V		
				6	-	-	1.8	-	1.8	-	1.8	V		
High Level Output		V <sub>IH</sub> or	-0.02	2	1.9	-	-	1.9	-	1.9	-	V		
Voltage CMOS Loads		V <sub>IL</sub>	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	٧		
omee Loads			-0.02	6	5.9	-	-	5.9	-	5.9	-	V		
High Level Output			-4	4.5	3.98	-	-	3.84	-	3.7	-	V		
Voltage TTL Loads			-5.2	6	5.48	-	-	5.34	-	5.2	-	٧		
Low Level Output	V <sub>OL</sub>	V <sub>IH</sub> or	0.02	2	-	-	0.1	-	0.1	-	0.1	٧		
Voltage CMOS Loads		$V_{IL}$	0.02	4.5	-	-	0.1	-	0.1	-	0.1	٧		
omee Loads			0.02	6	-	-	0.1	-	0.1	-	0.1	V		
Low Level Output	1		4	4.5	-	-	0.26	-	0.33	-	0.4	٧		
Voltage TTL Loads			5.2	6	ı	1	0.26	i	0.33	-	0.4	٧		
Input Leakage Current	II	V <sub>CC</sub> or GND	-	6	-	-	±0.1	-	±1	-	±1	μΑ		
Quiescent Device Current	Icc	V <sub>CC</sub> or GND	0	6	-	-	8	-	80	-	160	μΑ		

# DC Electrical Specifications (Continued)

		С	TEST ONDITION	ıs		25°C		-40°C T	O 85°C	-55°C TO 125°C		
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)	V <sub>CC</sub> (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HCT TYPES												
High Level Input Voltage	V <sub>IH</sub>	-	-	4.5 to 5.5	2	-	-	2	-	2	-	V
Low Level Input Voltage	V <sub>IL</sub>	-	-	4.5 to 5.5	-	-	0.8	-	0.8	-	0.8	V
High Level Output Voltage CMOS Loads	Voн	V <sub>IH</sub> or V <sub>IL</sub>	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
High Level Output Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V
Low Level Output Voltage CMOS Loads	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
Low Level Output Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lį	V <sub>CC</sub> to GND	-	5.5	-	-	±0.1	-	±1	-	±1	μА
Quiescent Device Current	Icc	V <sub>CC</sub> or GND	-	5.5	-	-	8	-	80	-	160	μА
Additional Quiescent Device Current Per Input Pin: 1 Unit Load	ΔI <sub>CC</sub> (Note 2)	V <sub>CC</sub> - 2.1	-	4.5 to 5.5	-	100	360	-	450	-	490	μА

#### NOTE:

#### **HCT Input Loading Table**

INPUT	UNIT LOADS
P0-P3	0.4
MR	1.45
PL	0.85
CPU, CPD	1.45

NOTE: Unit Load is  $\Delta I_{CC}$  limit specified in DC Electrical Specifications table, e.g. 360 $\mu$ A max at 25 $^{\circ}$ C.

<sup>2.</sup> For dual-supply systems theoretical worst case ( $V_I = 2.4V$ ,  $V_{CC} = 5.5V$ ) specification is 1.8mA.

# **Prerequisite For Switching Specifications**

			v <sub>cc</sub>		25°C		-40°C 1	O 85°C	-55°C TO 125°C		]
PARAMETER		SYMBOL	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES				-							
Pulse Width		t <sub>W</sub>	2	115	-	-	145	-	175	-	ns
CPU, CPD			4.5	23	-	-	29	-	35	-	ns
	192		6	20	-	-	25	-	30	-	ns
		t <sub>W</sub>	2	100	-	-	125	-	150	-	ns
CPU, CPD			4.5	20	-	-	25	-	30	-	ns
	193		6	17	-	-	21	-	26	-	ns
PL		t <sub>W</sub>	2	80	-	-	100	-	120	-	ns
			4.5	16	-	-	20	-	24	-	ns
			6	14	-	-	17	-	20	-	ns
MR		t <sub>W</sub>	2	100	-	-	125	-	150	-	ns
			4.5	20	-	-	25	-	30	-	ns
			6	17	-	-	21	-	26	-	ns
Set-up Time		tsu	2	80	-	-	100	-	120	-	ns
Pn to PL			4.5	16	-	-	20	-	24	-	ns
			6	14	-	-	17	-	20	-	ns
Hold Time		t <sub>H</sub>	2	0	-	-	0	-	0	-	ns
Pn to PL			4.5	0	-	-	0	-	0	-	ns
			6	0	-	-	0	-	0	-	ns
Hold Time		t <sub>H</sub>	2	80	-	-	100	-	120	-	ns
CPD to CPU or			4.5	16	-	-	20	-	24	-	ns
CPU to CPD			6	14	-	-	17	-	20	-	ns
Recovery Time		tREC	2	80	-	-	100	-	120	-	ns
PL to CPU, CPD			4.5	16	-	-	20	-	24	-	ns
			6	14	-	-	17	-	20	-	ns
MR to CPU, CPD		t <sub>REC</sub>	2	5	-	-	5	-	5	-	ns
			4.5	5	-	-	5	-	5	-	ns
			6	5	-	-	5	-	5	-	ns
Maximum Frequency		f <sub>MAX</sub>	2	5	-	-	4	-	3	-	MHz
CPU, CPD			4.5	22	-	-	18	-	15	-	MHz
	192		6	24	-	-	21	-	18	-	MHz
-		f <sub>MAX</sub>	2	5	-	-	4	-	3	-	MHz
CPU, CPD			4.5	25	-	-	20	-	17	-	MHz
	193		6	29	-	-	24	-	20	-	MHz
HCT TYPES			<u> </u>								
Pulse Width		t <sub>W</sub>	2	-	-	-	-	-	-	-	ns
CPU, CPD			4.5	23	-	-	29	-	35	-	ns
	192		6	-	-	-	-	-	-	-	ns
CPU, CPD		t <sub>W</sub>	2	-	-	-	-	-	-	-	ns
	193		4.5	23	-	-	29	-	35	-	ns
			6	-	-	-	-	-	-	-	ns

# Prerequisite For Switching Specifications (Continued)

		v <sub>cc</sub>		25°C		-40°C 1	ГО 85°C	-55°C TO 125°C		
PARAMETER	SYMBOL	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
PL	t <sub>W</sub>	2	-	-	-	-	-	-	-	ns
		4.5	16	-	-	20	-	24	-	ns
		6	-	-	-	-	-	-	-	ns
MR	t <sub>W</sub>	2	-	-	-	-	-	-	-	ns
		4.5	20	-	-	25	-	30	-	ns
		6	-	-	-	-	-	-	-	ns
Set-up Time	tsu	2	-	-	-	-	-	-	-	ns
Pn to PL		4.5	15	-	-	19	-	22	-	ns
		6	-	-	-	-	-	-	-	ns
Hold Time	t <sub>H</sub>	2	-	-	-	-	-	-	-	ns
Pn to PL		4.5	0	-	-	0	-	0	-	ns
		6	-	-	-	-	-	-	-	ns
Hold Time	t <sub>H</sub>	2	-	-	-	-	-	-	-	ns
CPD to CPU or		4.5	16	-	-	20	-	24	-	ns
CPU to CPD		6	-	-	-	-	-	-	-	ns
Recovery Time	tREC	2	-	-	-	-	-	-	-	ns
PL to CPU, CPD		4.5	15	-	-	19	-	22	-	ns
		6	-	-	-	-	-	-	-	ns
MR to CPU, CPD	tREC	2	-	-	-	-	-	-	-	ns
		4.5	5	-	-	5	-	5	-	ns
		6	-	-	-	-	-	-	-	ns
Maximum Frequency	f <sub>MAX</sub>	2	-	-	-	-	-	-	-	MHz
CPU, CPD		4.5	22	-	-	18	-	15	-	MHz
192	<u> </u>	6	-	-	-	-	-	-	-	MHz
CPU, CPD	f <sub>MAX</sub>	2	-	-	-	-	-	-	-	MHz
193	<b>;</b> [	4.5	22	-	-	18	-	15	-	MHz
		6	-	-	-	-	-	-	-	MHz

# Switching Specifications Input $t_r$ , $t_f = 6 \text{ns}$

		TEST	V <sub>CC</sub> (V)	25°C			-40°C TO 85°C		-55°C TO 125°C		
PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES	•										,
Propagation Delay	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	125	-	155	-	190	ns
CPU to TCU		C <sub>L</sub> = 50pF	4.5	-	-	25	-	31	-	38	ns
		C <sub>L</sub> = 15pF	5	-	10	-	-	-	-	-	ns
		C <sub>L</sub> = 50pF	6	-		21	-	26	-	32	ns
CPD to TCD	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	125	-	155	-	190	ns
		C <sub>L</sub> = 50pF	4.5	-	-	25	-	31	-	38	ns
		C <sub>L</sub> = 15pF	5	-	10	-	-	-	-	-	ns
		C <sub>L</sub> = 50pF	6	-	-	21	-	26	-	32	ns
CPU to Q <sub>n</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	220	-	270	-	325	ns
		C <sub>L</sub> = 50pF	4.5	-	-	43	-	54	-	65	ns
		C <sub>L</sub> = 15pF	5	-	18	-	-	-	-	-	ns
		C <sub>L</sub> = 50pF	6	-	-	37	-	46	-	55	ns

# Switching Specifications Input $t_{\rm r},\,t_{\rm f}=$ 6ns (Continued)

		TEST	v <sub>cc</sub>		25°C		-40°C T	O 85°C	-55°C TO 125°C		
PARAMETER	SYMBOL	CONDITIONS	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
CPD to Q <sub>n</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	220	-	270	-	325	ns
		C <sub>L</sub> = 50pF	4.5	-	-	43	-	54	-	65	ns
		C <sub>L</sub> = 15pF	5	-	18	-	-	-	-		ns
		C <sub>L</sub> = 50pF	6	-	-	37	-	46	-	55	ns
PL to Q <sub>n</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	220	-	275	-	330	ns
		C <sub>L</sub> = 50pF	4.5	-	-	44	-	55	-	66	ns
		C <sub>L</sub> = 15pF	5	-	18	-	-	-	-	-	ns
		C <sub>L</sub> = 50pF	6	-	-	37	-	47	-	56	ns
MR to Q <sub>n</sub>	t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	200	-	250	-	300	ns
		C <sub>L</sub> = 50pF	4.5	-	-	40	-	50	-	60	ns
		C <sub>L</sub> = 15pF	5	-	17	-	-	-	-	-	ns
		C <sub>L</sub> = 50pF	6	-	-	34	-	43	-	51	ns
Transition Time	t <sub>TLH</sub> , t <sub>THL</sub>	C <sub>L</sub> = 50pF	2	-	-	75	-	95	-	110	ns
Q, TCU, TCD			4.5	-	-	15	-	19	-	22	ns
			6	-	-	13	-	16	-	19	ns
Input Capacitance	C <sub>IN</sub>	C <sub>L</sub> = 50pF	-	-	-	10	-	10	-	10	pF
Power Dissipation Capacitance (Notes 3, 4)	C <sub>PD</sub>	C <sub>L</sub> = 15pF	5	-	40	-	-	-	-	-	pF
HCT TYPES		•	•								
Propagation Delay	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	27	-	34	-	41	ns
CPU to TCU		C <sub>L</sub> = 15pF	5	-	11	-	-	-	-	-	ns
CPU to TCD	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	27	-	34	-	41	ns
		C <sub>L</sub> = 15pF	5	-	11	-	-	-	-	-	ns
CPU to Q <sub>n</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	40	-	50	-	60	ns
		C <sub>L</sub> = 15pF	5	-	17	-	-	-	-	-	ns
CPD to Q <sub>n</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	40	-	50	-	60	ns
		C <sub>L</sub> = 15pF	5	-	17	-	-	-	-	-	ns
PL to Q <sub>n</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	46	-	58	-	69	ns
		C <sub>L</sub> = 15pF	5	-	21	-	-	-	-	-	ns
MR to Q <sub>n</sub>	t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	43	-	54	-	65	ns
		C <sub>L</sub> = 15pF	5	-	18	-	-	-	-	-	ns
Transition Time	t <sub>TLH</sub> , t <sub>THL</sub>	C <sub>L</sub> = 50pF									
Q, TCU, TCD			4.5	-	-	15	-	19	-	22	ns
Input Capacitance	C <sub>IN</sub>	C <sub>L</sub> = 50pF	-	-	-	10	-	10	-	10	pF
Power Dissipation Capacitance (Notes 3, 4)	C <sub>PD</sub>	C <sub>L</sub> = 15pF	5	-	50	-	-	-	-	-	pF

<sup>3.</sup>  $C_{PD}$  is used to determine the dynamic power consumption, per gate.

4.  $P_D = V_{CC}^2 f_i + \sum (C_L V_{CC}^2)$  where  $f_i$  = Input Frequency,  $C_L$  = Output Load Capacitance,  $V_{CC}$  = Supply Voltage.

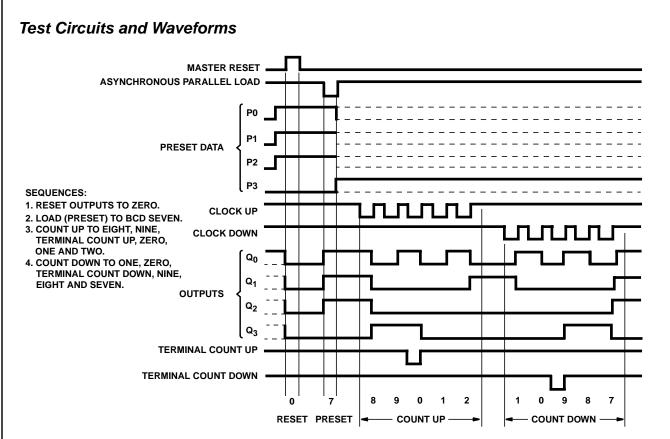


FIGURE 1. 'HC192 SYNCHRONOUS DECADE COUNTERS, TYPICAL RESET, PRESET AND COUNT SEQUENCES

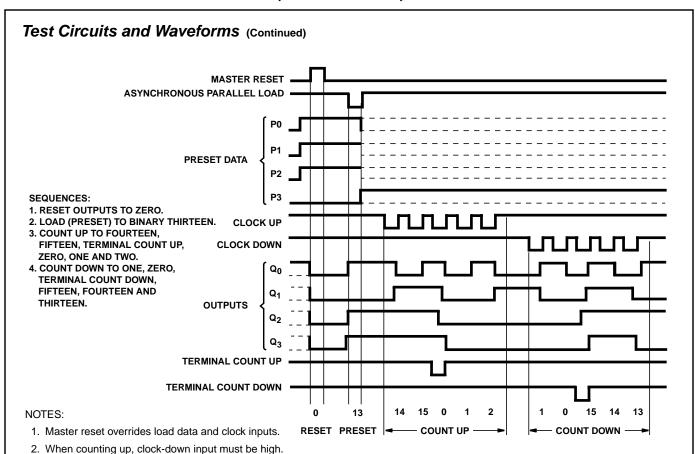
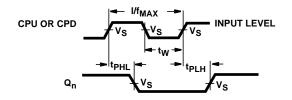


FIGURE 2. 'HC193 SYNCHRONOUS BINARY COUNTERS, TYPICAL RESET, PRESET AND COUNT SEQUENCES



When counting down, clock-up input must be high.



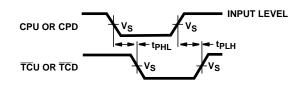


FIGURE 4. CLOCK TO TERMINAL COUNT DELAYS

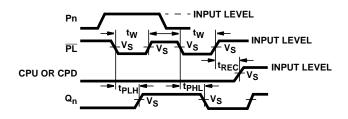


FIGURE 5. PARALLEL LOAD PULSE WIDTH, PARALLEL LOAD TO OUTPUT DELAYS, AND PARALLEL LOAD TO CLOCK RECOVERY TIME

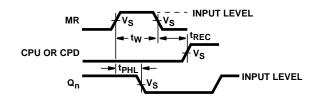


FIGURE 6. MASTER RESET PULSE WIDTH, MASTER RESET TO OUTPUT DELAY AND MASTER RESET TO CLOCK RECOVERY TIME

# Test Circuits and Waveforms (Continued)

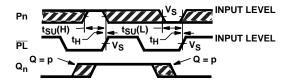


FIGURE 7. SET-UP AND HOLD TIMES DATA TO PARALLEL LOAD (PL)

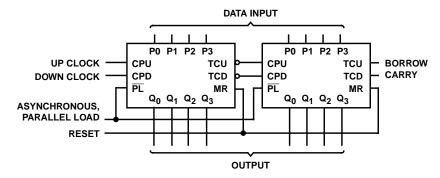
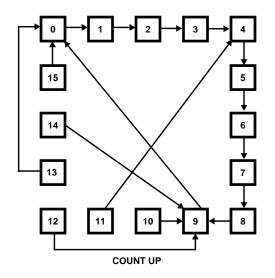
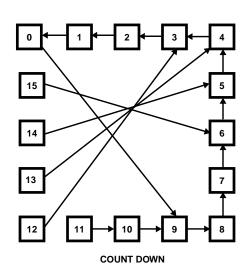


FIGURE 8. CASCADED UP/DOWN COUNTER WITH PARALLEL LOAD





NOTE: Illegal states in BCD counters corrected in one count.

NOTE: Illegal states in BCD counters corrected in one or two counts.

FIGURE 9. 'HC192, 'HC1193 STATE DIAGRAMS

# **PACKAGE OPTION ADDENDUM**



4-Feb-2021

#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-8780801EA	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8780801EA CD54HC192F3A	Samples
5962-9084801MEA	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9084801ME A CD54HCT193F3A	Samples
CD54HC192F3A	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8780801EA CD54HC192F3A	Samples
CD54HC193F3A	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8772401EA CD54HC193F3A	Samples
CD54HCT193F3A	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9084801ME A CD54HCT193F3A	Samples
CD74HC192E	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC192E	Samples
CD74HC192NSR	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC192M	Samples
CD74HC192NSRG4	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC192M	Samples
CD74HC192PWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ192	Samples
CD74HC192PWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ192	Samples
CD74HC192PWT	ACTIVE	TSSOP	PW	16	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ192	Samples
CD74HC193E	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC193E	Samples
CD74HC193M	ACTIVE	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC193M	Samples
CD74HC193M96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC193M	Samples
CD74HC193M96E4	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC193M	Samples
CD74HC193MT	ACTIVE	SOIC	D	16	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC193M	Samples
CD74HCT193E	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT193E	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

#### PACKAGE OPTION ADDENDUM



4-Feb-2021

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF CD54HC192, CD54HC193, CD54HCT193, CD74HC192, CD74HC193, CD74HCT193:

- Catalog: CD74HC192, CD74HC193, CD74HCT193
- Military: CD54HC192, CD54HC193, CD54HCT193

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product



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# **PACKAGE OPTION ADDENDUM**

4-Feb-2021

• Military - QML certified for Military and Defense Applications

**PACKAGE MATERIALS INFORMATION** 

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#### TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC192NSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD74HC192PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC192PWT	TSSOP	PW	16	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC193M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

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\*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC192NSR	SO	NS	16	2000	853.0	449.0	35.0
CD74HC192PWR	TSSOP	PW	16	2000	853.0	449.0	35.0
CD74HC192PWT	TSSOP	PW	16	250	853.0	449.0	35.0
CD74HC193M96	SOIC	D	16	2500	333.2	345.9	28.6

# D (R-PDS0-G16)

#### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



# D (R-PDSO-G16)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



#### **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



#### 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



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